

SI4800

N-channel TrenchMOS™ logic level FET

Rev. 02 — 17 February 2004

Product data

1. Product profile

1.1 Description

N-channel enhancement mode field-effect transistor in a plastic package using TrenchMOS™ technology.

1.2 Features

- Low gate charge
- Low on-state resistance
- Surface mounted package
- Fast switching.

1.3 Applications

- Portable appliances
- Lithium-ion battery chargers
- Notebook computers
- DC-to-DC converters.

1.4 Quick reference data

- $V_{DS} \leq 30$ V
- $I_D \leq 9$ A
- $P_{tot} \leq 2.5$ W
- $R_{DSon} \leq 18.5$ mΩ

2. Pinning information

Table 1: Pinning - SOT96-1 (SO-8), simplified outline and symbol

Pin	Description	Simplified outline	Symbol
1,2,3	source (s)	<p>Top view MBK187</p> <p>SOT96-1 (SO8)</p>	<p>MBB076</p>
4	gate (g)		
5,6,7,8	drain (d)		



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3. Ordering information

Table 2: Ordering information

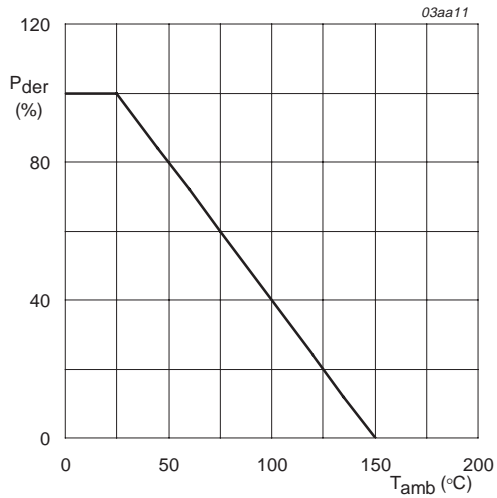
Type number	Package		
	Name	Description	Version
SI4800	SO8	plastic small outline package; 8 leads	SOT96-1

4. Limiting values

Table 3: Limiting values

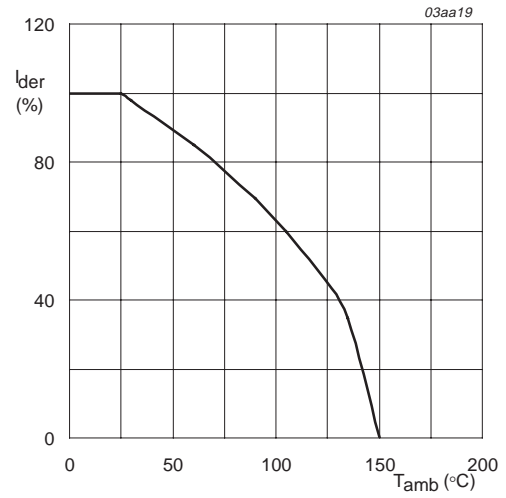
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage (DC)	$25\text{ °C} \leq T_j \leq 150\text{ °C}$	-	30	V
V_{GS}	gate-source voltage (DC)		-	± 20	V
I_D	drain current	$T_{amb} = 25\text{ °C}$; pulsed; $t_p \leq 10\text{ s}$; Figure 2 and 3	-	9	A
		$T_{amb} = 70\text{ °C}$; pulsed; $t_p \leq 10\text{ s}$; Figure 2	-	7	A
I_{DM}	peak drain current	$T_{amb} = 25\text{ °C}$; pulsed; $t_p \leq 10\text{ }\mu\text{s}$; Figure 3	-	40	A
P_{tot}	total power dissipation	$T_{amb} = 25\text{ °C}$; pulsed; $t_p \leq 10\text{ s}$; Figure 1	-	2.5	W
		$T_{amb} = 70\text{ °C}$; pulsed; $t_p \leq 10\text{ s}$; Figure 1	-	1.6	W
T_{stg}	storage temperature		-55	+150	°C
T_j	junction temperature		-55	+150	°C
Source-drain diode					
I_S	source (diode forward) current	$T_{amb} = 25\text{ °C}$; pulsed; $t_p \leq 10\text{ s}$	-	2.3	A



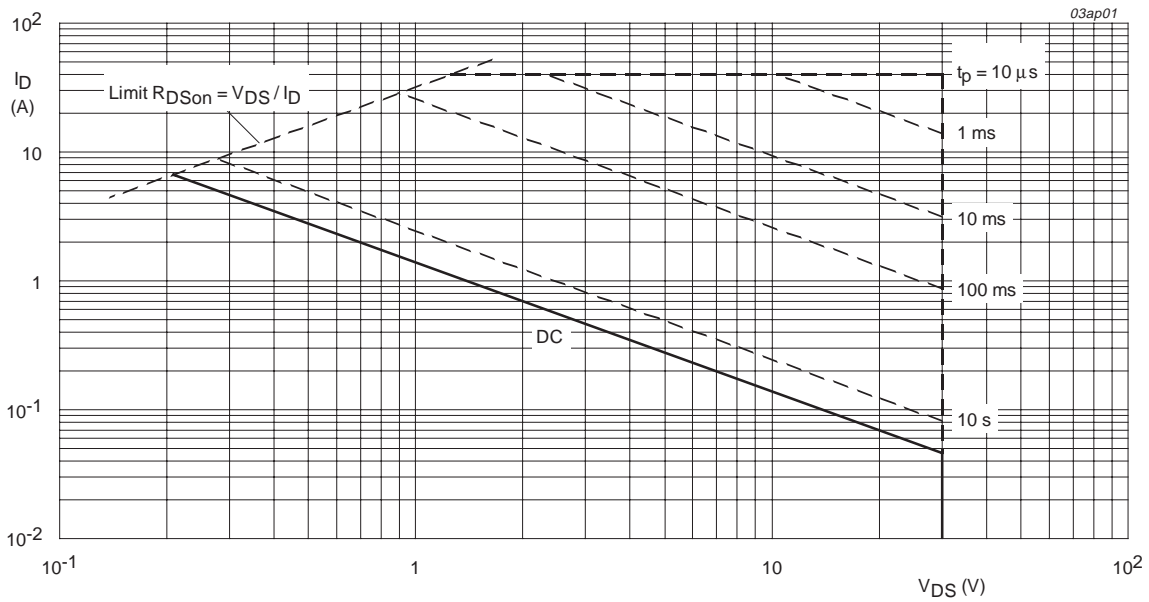
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 1. Normalized total power dissipation as a function of ambient temperature.



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of ambient temperature.



T_{amb} = 25 °C; I_{DM} is single pulse.

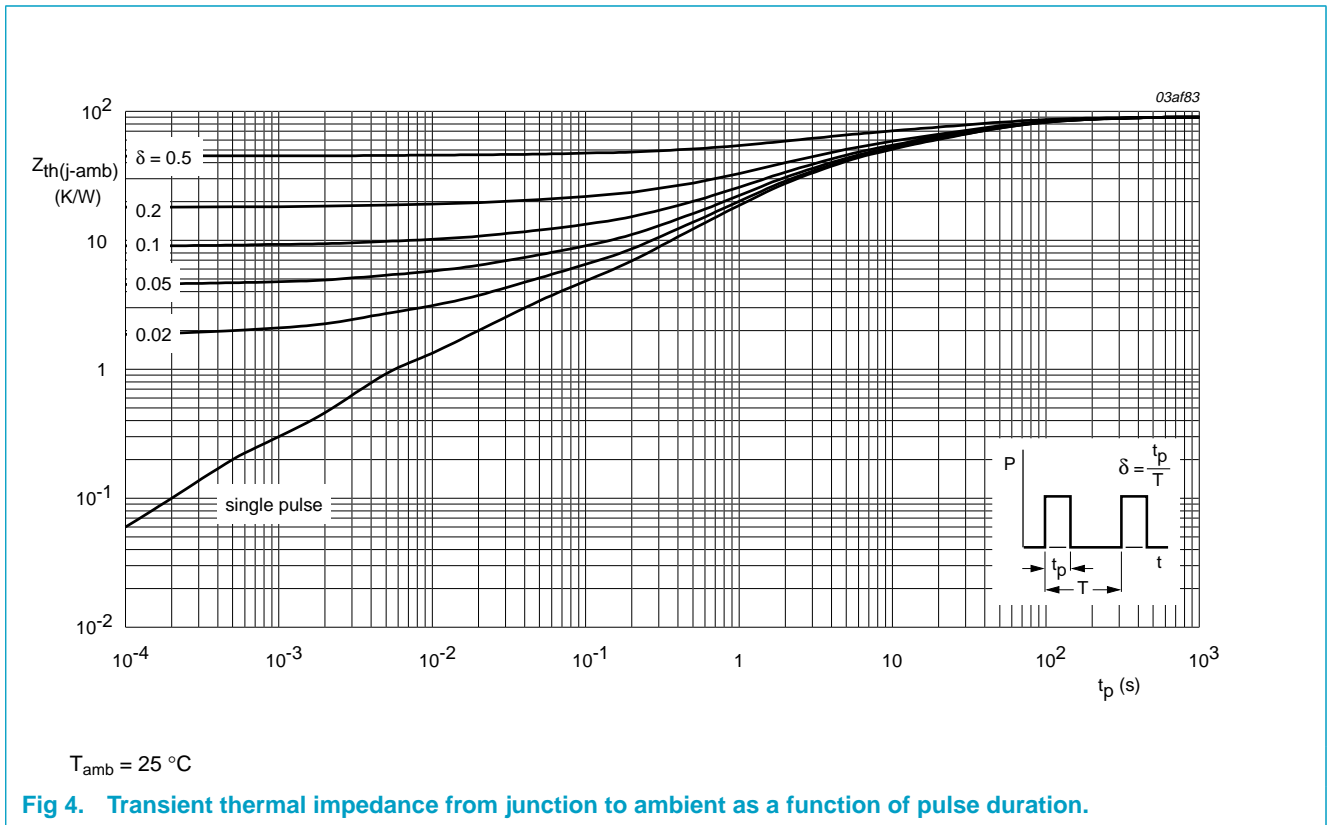
Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

5. Thermal characteristics

Table 4: Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	mounted on a printed-circuit board; minimum footprint; $t_p \leq 10$ s; Figure 4	-	-	50	K/W

5.1 Transient thermal impedance

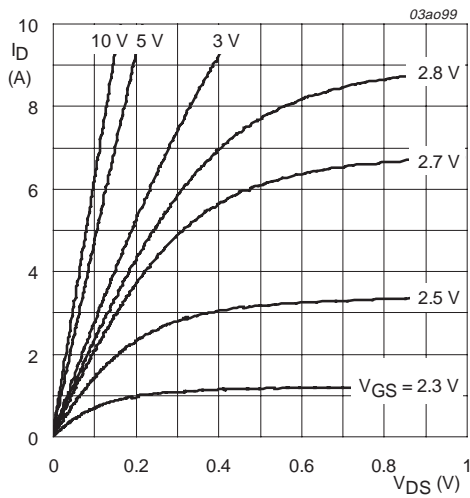


6. Characteristics

Table 5: Characteristics

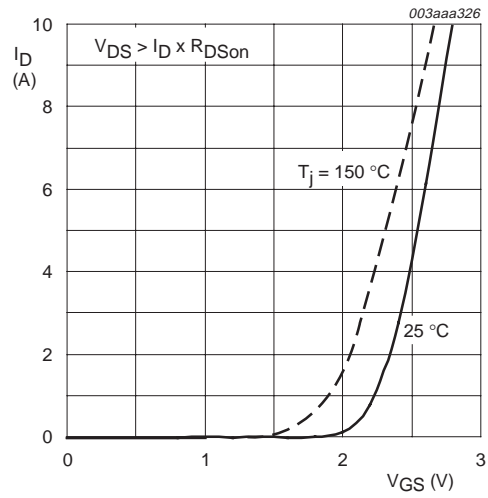
$T_j = 25\text{ °C}$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 250\ \mu\text{A}$; $V_{DS} = V_{GS}$; Figure 9	0.8	-	-	V
I_{DSS}	drain-source leakage current	$V_{DS} = 24\ \text{V}$; $V_{GS} = 0\ \text{V}$	-	-	1	μA
		$T_j = 25\text{ °C}$	-	-	5	μA
		$T_j = 55\text{ °C}$	-	-	5	μA
I_{GSS}	gate-source leakage current	$V_{GS} = \pm 20\ \text{V}$; $V_{DS} = 0\ \text{V}$	-	-	100	nA
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 10\ \text{V}$; $I_D = 9\ \text{A}$; Figure 7 and 8	-	15.5	18.5	m Ω
		$V_{GS} = 4.5\ \text{V}$; $I_D = 7\ \text{A}$; Figure 7	-	24	33	m Ω
$I_{D(on)}$	on-state drain current	$V_{DS} \geq 5\ \text{V}$; $V_{GS} = 10\ \text{V}$	30	-	-	A
Dynamic characteristics						
g_{fs}	forward transconductance	$V_{DS} = 15\ \text{V}$; $I_D = 9\ \text{A}$	-	19	-	S
$Q_{g(tot)}$	total gate charge	$I_D = 8\ \text{A}$; $V_{DD} = 15\ \text{V}$; $V_{GS} = 5\ \text{V}$; Figure 13	-	11.8	-	nC
Q_{gs}	gate-source charge		-	2.7	-	nC
Q_{gd}	gate-drain (Miller) charge		-	5	-	nC
$t_{d(on)}$	turn-on delay time	$V_{DD} = 15\ \text{V}$; $I_D = 1.5\ \text{A}$; $V_{GS} = 10\ \text{V}$; $R_G = 6\ \Omega$	-	6	16	ns
t_r	rise time		-	7	15	ns
$t_{d(off)}$	turn-off delay time		-	23	30	ns
t_f	fall time		-	11	15	ns
Source-drain diode						
V_{SD}	source-drain (diode forward) voltage	$I_S = 7\ \text{A}$; $V_{GS} = 0\ \text{V}$; Figure 12	-	0.86	1.2	V
t_{rr}	reverse recovery time	$I_S = 7\ \text{A}$; $di_S/dt = -100\ \text{A}/\mu\text{s}$; $V_R = 30\ \text{V}$; $V_{GS} = 0\ \text{V}$	-	25	80	ns



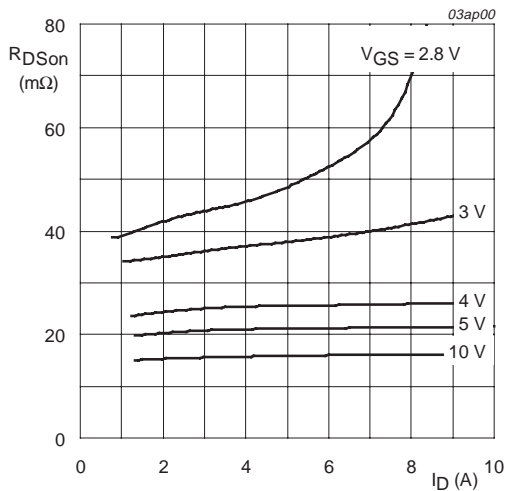
$T_j = 25\text{ }^\circ\text{C}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.



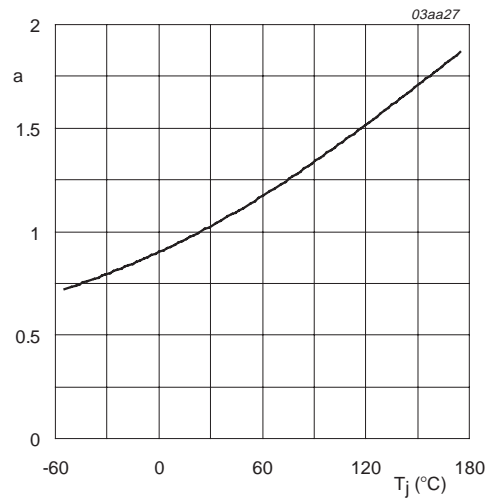
$T_j = 25\text{ }^\circ\text{C}$ and $150\text{ }^\circ\text{C}$; $V_{DS} > I_D \times R_{DSon}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values.



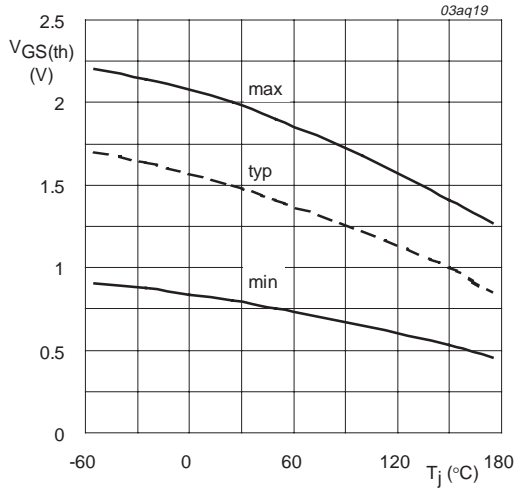
$T_j = 25\text{ }^\circ\text{C}$

Fig 7. Drain-source on-state resistance as a function of drain current; typical values.



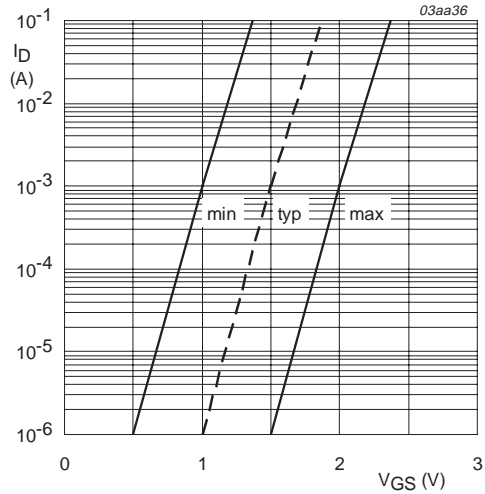
$$a = \frac{R_{DSon}}{R_{DSon}(25^\circ\text{C})}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature.



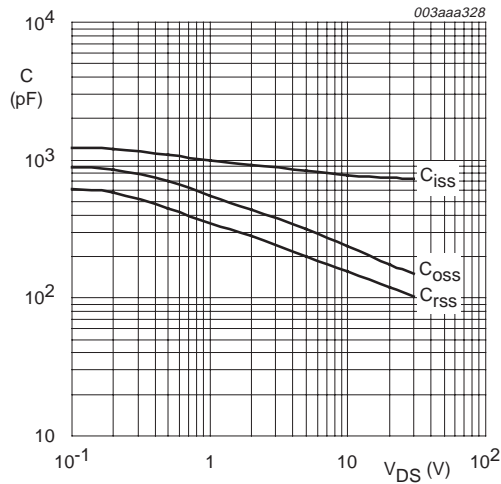
$I_D = 250 \mu A$; $V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature.



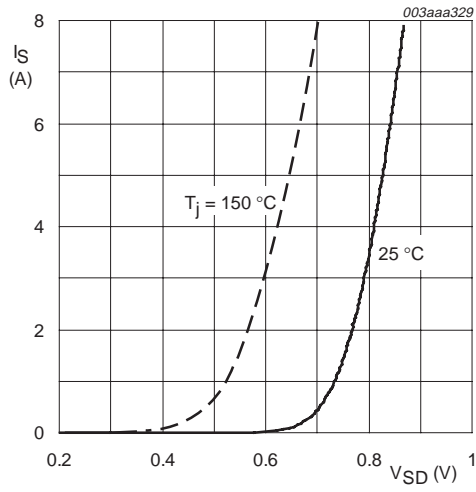
$T_j = 25 \text{ }^\circ\text{C}$; $V_{DS} = 5 \text{ V}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage.



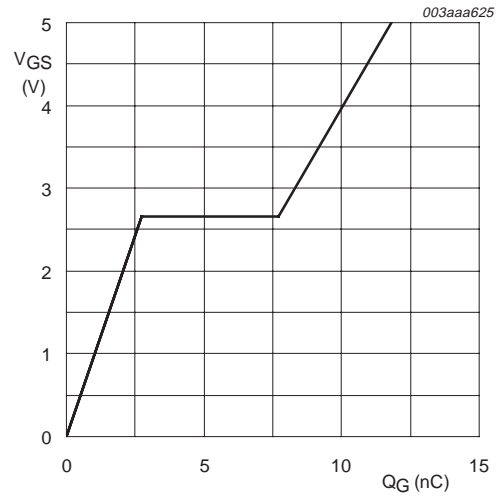
$V_{GS} = 0 \text{ V}$; $f = 1 \text{ MHz}$

Fig 11. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.



$T_j = 25\text{ }^\circ\text{C}$ and $150\text{ }^\circ\text{C}$; $V_{GS} = 0\text{ V}$

Fig 12. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.



$I_D = 8\text{ A}$; $V_{DD} = 15\text{ V}$

Fig 13. Gate-source voltage as a function of gate charge; typical values.

7. Package outline

SO8: plastic small outline package; 8 leads; body width 3.9 mm

SOT96-1

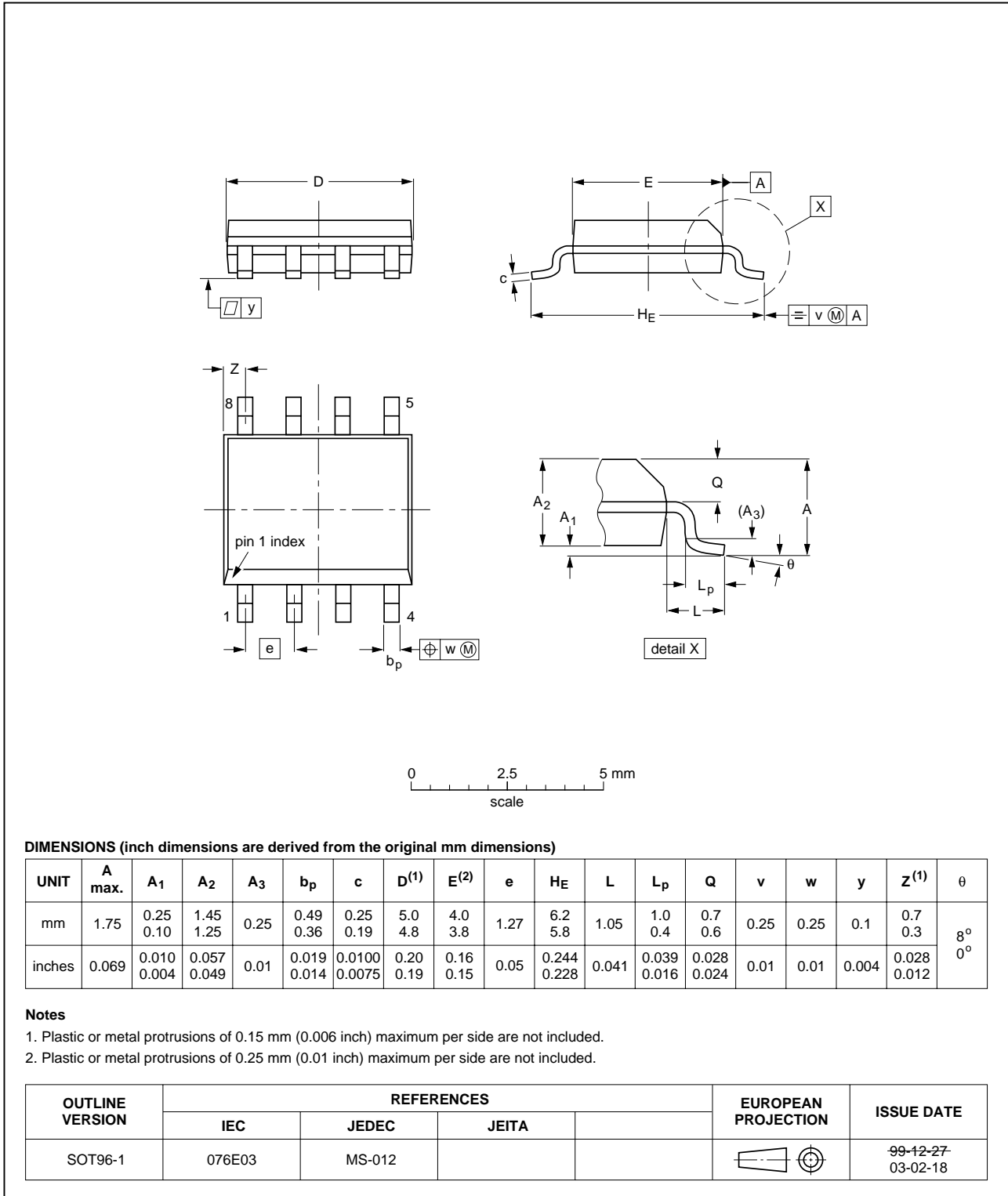


Fig 14. SOT96-1 (SO8).

8. Revision history

Table 6: Revision history

Rev	Date	CPCN	Description
02	20040217	-	Product data (9397 750 12899) Modifications: <ul style="list-style-type: none"> • Updated to latest standards. • Section 3 “Ordering information” added. • Section 5 “Thermal characteristics” clarification of thermal resistance table. • Section 6 “Characteristics” typical R_{DSon} value improved. • Section 6 “Characteristics” typical $Q_{g(tot)}$, Q_{gs} and Q_{gd} values improved. • Section 6 “Characteristics” $t_{d(on)}$, t_r, $t_{d(off)}$ and t_f conditions and typical values modified. • Section 6 “Characteristics” V_{SD} conditions, and typical value modified. • Section 6 “Characteristics” t_{rr} conditions and typical value modified • Section 6 “Characteristics” Figure 5, 6, 7, 11, 12 and 13 modified.
01	20010713	-	Product data (9397 750 08412)

9. Data sheet status

Level	Data sheet status ^[1]	Product status ^{[2][3]}	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

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For sales office addresses, send e-mail to: sales.addresses@www.semiconductors.philips.com.

Fax: +31 40 27 24825

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